

# **MOSFET**

### OptiMOS<sup>™</sup> Power-MOSFET, 30 V

### **Features**

- Optimized SyncFET for high performance buck converter Integrated monolithic Schottky-like diode Very low on-resistance  $R_{\rm DS(on)}$  @  $V_{\rm GS}$ =4.5 V

- 100% avalanche tested
- Superior thermal resistance
- N-channel
- Qualified according to JEDEC<sup>1)</sup> for target applications
  Pb-free lead plating; RoHS compliant
  Halogen-free according to IEC61249-2-21

Table 1 **Key Performance Parameters** 

Parameter	Value	Unit
$V_{ extsf{DS}}$	30	V
R <sub>DS(on),max</sub>	2.8	mΩ
I <sub>D</sub>	100	A
Qoss	17	nC
Q <sub>G</sub> (0V10V)	24	nC











Type / Ordering Code	Package	Marking	Related Links
BSC0902NSI	PG-TDSON-8	0902NSI	-

# OptiMOS<sup>™</sup> Power-MOSFET, 30 V BSC0902NSI



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# OptiMOS™ Power-MOSFET, 30 V BSC0902NSI



# 1 Maximum ratings at $T_A$ =25 °C, unless otherwise specified

Table 2 Maximum ratings

Damanadan	0		Value	s			
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Continuous drain current	I <sub>D</sub>	- - - -	- - - -	100 65 89 56 23	A	$V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =10 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =4.5 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =4.5 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =10 V, $T_{\rm A}$ =25 °C, $R_{\rm thJA}$ =50 K/W <sup>1)</sup>	
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	-	-	400	Α	<i>T</i> <sub>C</sub> =25 °C	
Avalanche current, single pulse <sup>3)</sup>	I <sub>AS</sub>	-	-	50	Α	<i>T</i> <sub>C</sub> =25 °C	
Avalanche energy, single pulse	E <sub>AS</sub>	-	-	30	mJ	$I_{\rm D}$ =40 A, $R_{\rm GS}$ =25 $\Omega$	
Gate source voltage	V <sub>GS</sub>	-20	-	20	V	-	
Power dissipation	P <sub>tot</sub>	-	-	48 2.5	W	T <sub>C</sub> =25 °C T <sub>A</sub> =25 °C, R <sub>thJA</sub> =50 K/W <sup>1)</sup>	
Operating and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55	-	150	°C	IEC climatic category; DIN IEC 68-1: 55/150/56	

#### 2 Thermal characteristics

Table 3 **Thermal characteristics** 

Parameter	Symbol	Values			Unit	Note / Test Condition
raiailletei	Symbol	Min.	Тур.	Max.	Ullit	Note / Test Condition
Thermal resistance, junction - case, bottom	R <sub>thJC</sub>	-	-	2.6	K/W	-
Thermal resistance, junction - case, top	R <sub>thJC</sub>	-	-	20	K/W	-
Device on PCB, 6 cm <sup>2</sup> cooling area <sup>1)</sup>	R <sub>thJA</sub>	-	-	50	K/W	-

 $<sup>^{1)}</sup>$  Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm2 (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.  $^{2)}$  See Diagram 3 for more detailed information  $^{3)}$  See Diagram 13 for more detailed information



### 3 Electrical characteristics

**Table 4** Static characteristics

Parameter	Oh. a.l.	Values				
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	30	-	-	V	V <sub>GS</sub> =0 V, I <sub>D</sub> =10 mA
Breakdown voltage temperature coefficient	$dV_{(BR)DSS}/dT_{j}$	-	15	-	mV/K	I <sub>D</sub> =10 mA, referenced to 25 °C
Gate threshold voltage	V <sub>GS(th)</sub>	1.2	-	2	V	$V_{\rm DS}$ = $V_{\rm GS}$ , $I_{\rm D}$ =10 mA
Zero gate voltage drain current	I <sub>DSS</sub>	-	- 2	0.5	mA	V <sub>DS</sub> =24 V, V <sub>GS</sub> =0 V V <sub>DS</sub> =24 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =125 °C
Gate-source leakage current	I <sub>GSS</sub>	-	10	100	nA	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	3.0 2.3	3.7 2.8	mΩ	V <sub>GS</sub> =4.5 V, I <sub>D</sub> =30 A V <sub>GS</sub> =10 V, I <sub>D</sub> =30 A
Gate resistance	R <sub>G</sub>	0.5	0.9	1.8	Ω	-
Transconductance	<b>G</b> fs	50	100	-	S	V <sub>DS</sub>  >2 I <sub>D</sub>  R <sub>DS(on)max</sub> , I <sub>D</sub> =30 A

 Table 5
 Dynamic characteristics

Parameter	0	Values			1114	
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	Ciss	-	1500	2000	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =15 V, <i>f</i> =1 MHz
Output capacitance	Coss	-	630	840	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =15 V, <i>f</i> =1 MHz
Reverse transfer capacitance	C <sub>rss</sub>	-	88	-	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =15 V, <i>f</i> =1 MHz
Turn-on delay time	$t_{\sf d(on)}$	-	3.9	-	ns	$V_{\rm DD}$ =15 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Rise time	t <sub>r</sub>	-	5.4	-	ns	$V_{\rm DD}$ =15 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Turn-off delay time	$t_{ m d(off)}$	-	20	-	ns	$V_{\rm DD}$ =15 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Fall time	t <sub>f</sub>	-	3.8	-	ns	$V_{\rm DD}$ =15 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 $\Omega$

Table 6 Gate charge characteristics<sup>1)</sup>

Parameter			Values			
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q <sub>gs</sub>	-	4.0	-	nC	$V_{\rm DD}$ =15 V, $I_{\rm D}$ =30 A, $V_{\rm GS}$ =0 to 4.5 V
Gate charge at threshold	$Q_{g(th)}$	-	2.4	-	nC	$V_{\rm DD}$ =15 V, $I_{\rm D}$ =30 A, $V_{\rm GS}$ =0 to 4.5 V
Gate to drain charge	$Q_{ m gd}$	-	4.0	-	nC	$V_{\rm DD}$ =15 V, $I_{\rm D}$ =30 A, $V_{\rm GS}$ =0 to 4.5 V
Switching charge	Q <sub>sw</sub>	-	5.6	-	nC	$V_{\rm DD}$ =15 V, $I_{\rm D}$ =30 A, $V_{\rm GS}$ =0 to 4.5 V
Gate charge total	Qg	-	12.2	16.2	nC	$V_{\rm DD}$ =15 V, $I_{\rm D}$ =30 A, $V_{\rm GS}$ =0 to 4.5 V
Gate plateau voltage	V <sub>plateau</sub>	-	2.6	-	V	$V_{\rm DD}$ =15 V, $I_{\rm D}$ =30 A, $V_{\rm GS}$ =0 to 4.5 V
Gate charge total	Qg	-	24	32	nC	$V_{\rm DD}$ =15 V, $I_{\rm D}$ =30 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total, sync. FET	Q <sub>g(sync)</sub>	-	9.8	-	nC	V <sub>DS</sub> =0.1 V, V <sub>GS</sub> =0 to 4.5 V
Output charge	Qoss	-	17	23	nC	V <sub>DD</sub> =15 V, V <sub>GS</sub> =0 V

<sup>1)</sup> See "Gate charge waveforms" for parameter definition

# OptiMOS<sup>™</sup> Power-MOSFET, 30 V BSC0902NSI

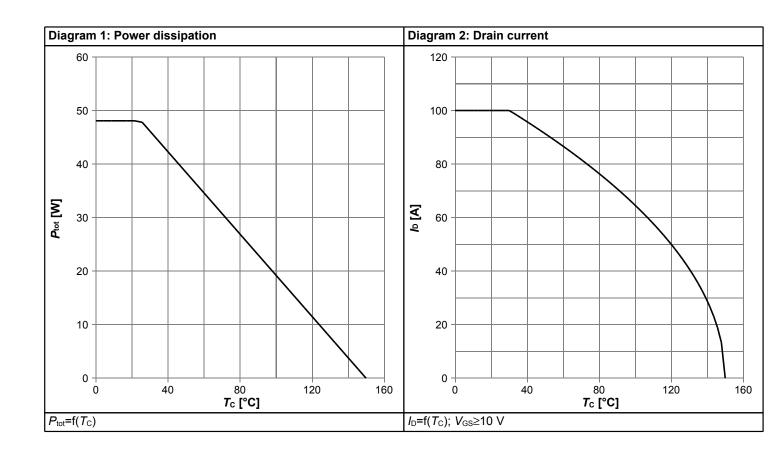


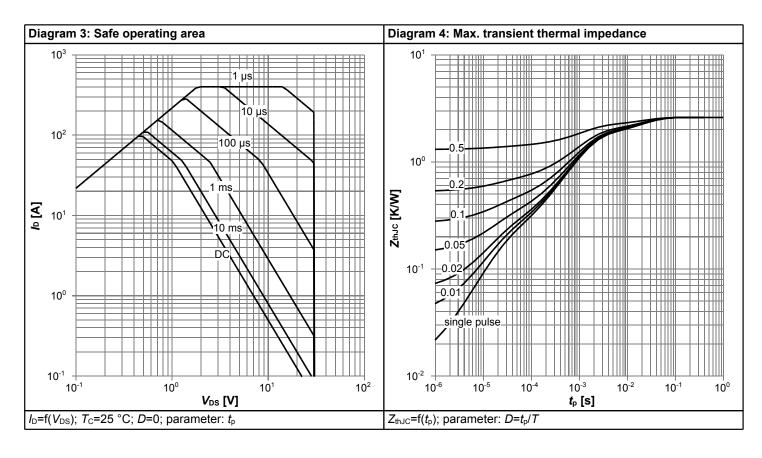
### Table 7 Reverse diode

Doromotor	Symbol		Values			Note / Test Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode continuous forward current	Is	-	-	48	Α	<i>T</i> <sub>C</sub> =25 °C
Diode pulse current	I <sub>S,pulse</sub>	-	-	192	Α	<i>T</i> <sub>C</sub> =25 °C
Diode forward voltage	V <sub>SD</sub>	-	0.54	0.7	V	V <sub>GS</sub> =0 V, I <sub>F</sub> =4 A, T <sub>j</sub> =25 °C
Reverse recovery charge	Qrr	-	5	-	nC	$V_R$ =15 V, $I_F$ =4 A, $di_F/dt$ =400 A/ $\mu$ s

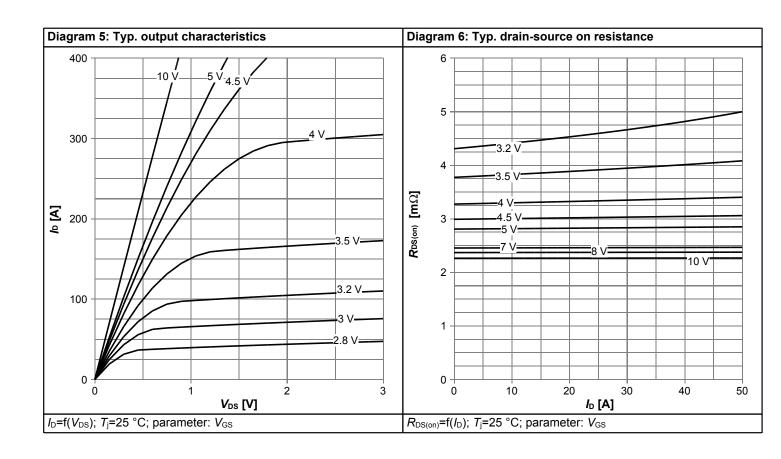


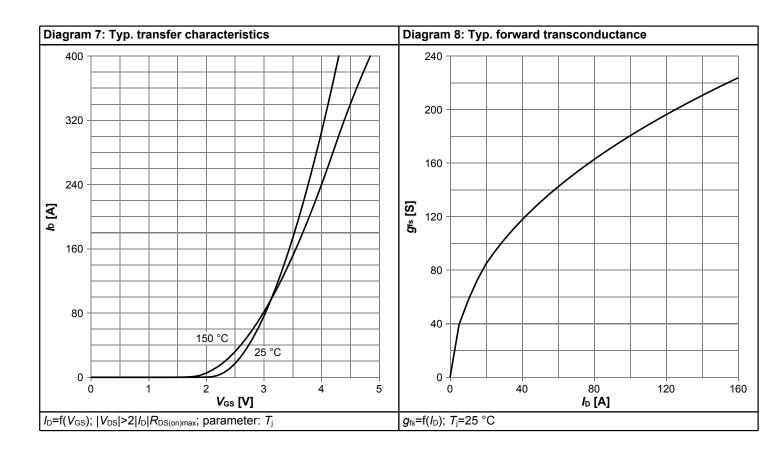
# 4 Electrical characteristics diagrams



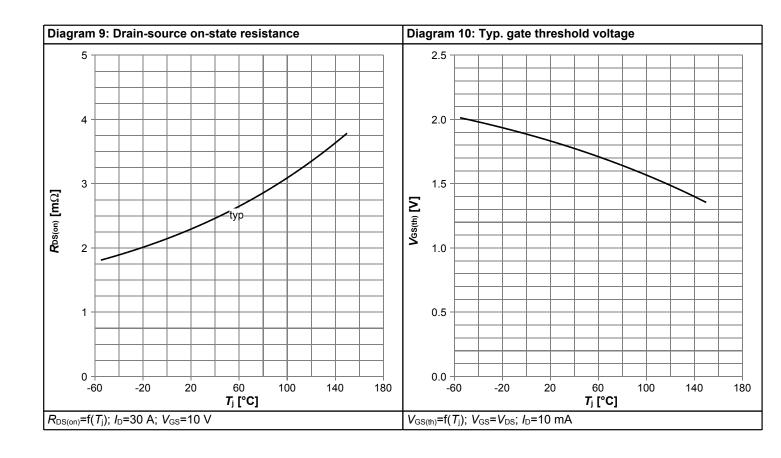


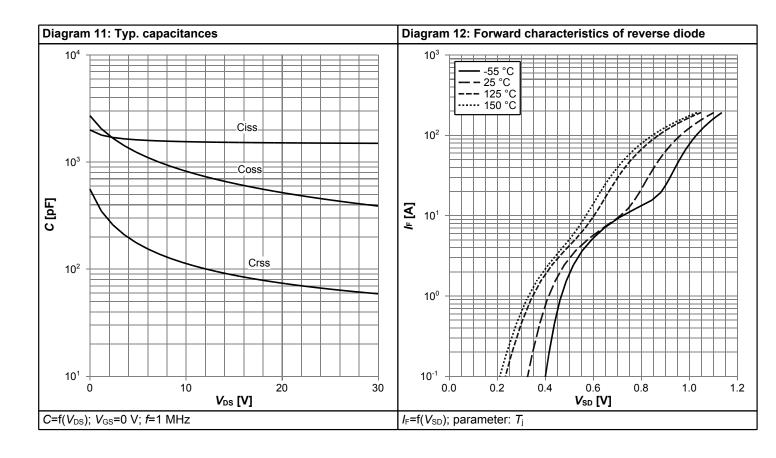




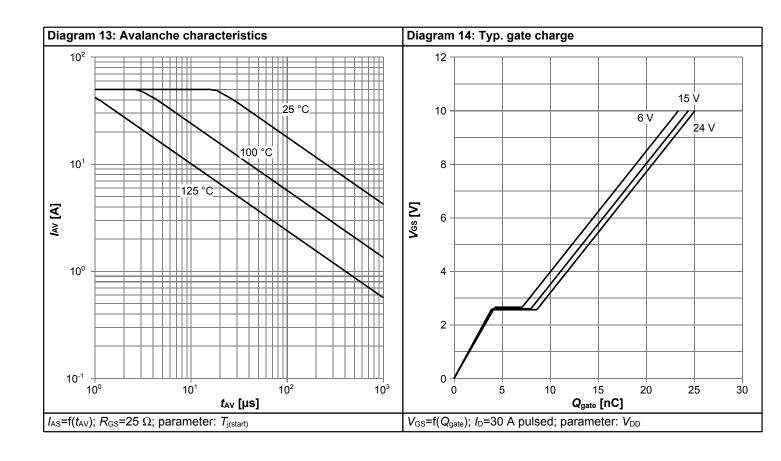


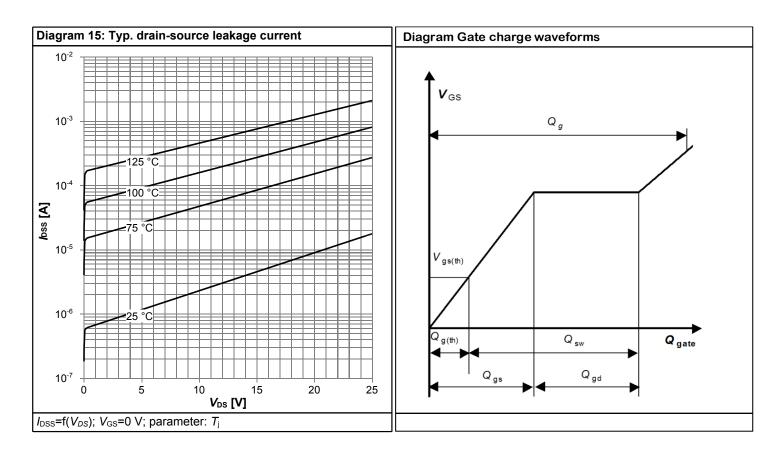






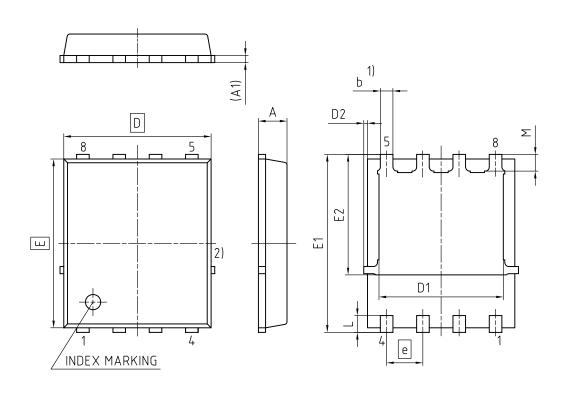








# 5 Package Outlines



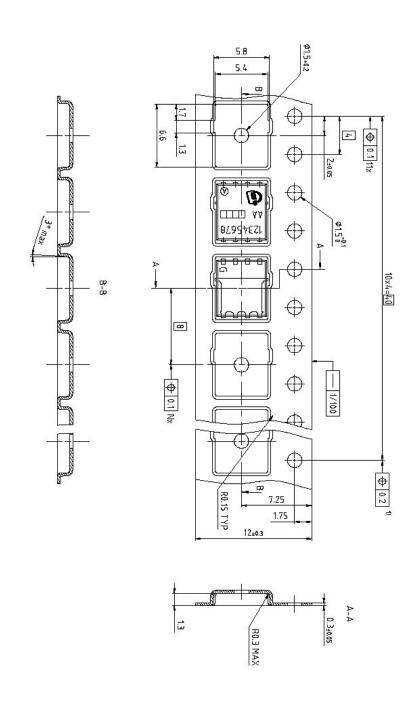
1) EXCLUDING MOLD FLASH
2) REMOVAL ON MOLD GATE
INTRUSION 0.1 MM
PROTRUSION 0.1 MM
LEAD LENGTH UP TO ANTI FLASH LINE
ALL METAL SURFACES ARE PLATED, EXCEPT AREA OF CUT

DIMENSION	MILLIMETERS						
DIMENSION	MIN.	MAX.					
Α	0.90	1.20					
A1	0.15	0.35					
b	0.34	0.54					
D	4.80	5.35					
D1	3.90	4.40					
D2	0.03	0.23					
E	5.70	6.10					
E1	5.90	6.42					
E2	3.88	4.31					
е	1.27						
L	0.45	0.71					
М	0.45	0.69					

DOCUMENT NO. Z8B00003332					
REVISION 07					
SCALE 10:1					
0 1 2 3mm					
EUROPEAN PROJECTION					
ISSUE DATE					
06.06.2019					

Figure 1 Outline PG-TDSON-8, dimensions in mm





Dimension in mm

Figure 2 Outline Tape (TDSON-8)



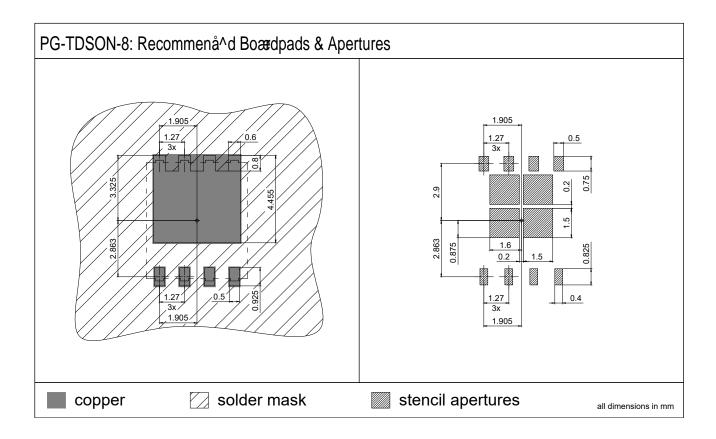


Figure 3 Outline Boardpads (TDSON-8), dimensions in mm

# OptiMOS TM Power-MOSFET, 30 V BSC0902NSI



### **Revision History**

### BSC0902NSI

Revision: 2019-11-13, Rev. 2.4

### **Previous Revision**

Revision	Date	ubjects (major changes since last revision)				
2.3	2016-02-03	Update Coss max				
2.4	2019-11-13	Update package drawings				

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